Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/624,386	FERNANDEZ, JORGE D.
Examiner	Art Unit

Matsuichiro Shimizu

2635

	SEARCHED			
Class	Subclass	Date	Examiner	
340	7.4	9/29/05	ny	
	7.4 7.44 825.44 825.16	<i>j</i> ,	1	
340	x25.16			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
340	7.4	9/29/05	ns	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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